Search Notes



Application/Control No.	Applicant(s)/Patent under Reexamination	
10/592,018	FRANKE ET AL.	
Examiner	Art Unit	
Tan V. Mai	2193	

SEARCHED						
Class	Subclass	Date	Examiner			
708	250-256	10/6/2008	MAI			
	-					

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
708	255	10/6/2008	MAJ		
interferer	t search (see nce search ntout)	10/6/2008	MAI		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Inventor(s) search Double Patent Check Data Bases Search (see search history printout(s))	10/1/2008	MAI		